DATA SHEET

BUT12; BUT12A
Silicon diffused power transistors

Product specification
Supersedes data of February 1996
File under Discrete Semiconductors, SC06

1997 Aug 13

Philips Semiconductors

Silicon diffused power transistors BUT12; BUT12A

DESCRIPTION

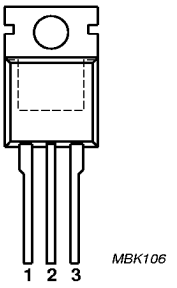
High-voltage, high-speed, glass-passivated NPN power transistor in a TO-220AB package.

APPLICATIONS

- Converters
- Inverters
- Switching regulators
- Motor control systems.

PINNING

PIN	DESCRIPTION
1	base
2	collector; connected to mounting base
3	emitter



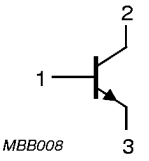


Fig.1 Simplified outline (TO-220AB) and symbol.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
V_{CESM}	collector-emitter peak voltage	V_{BE} = 0		
	BUT12		850	V
	BUT12A		1000	V
V_{CEO}	collector-emitter voltage	open base		
	BUT12		400	V
	BUT12A		450	V
V_{CEsat}	collector-emitter saturation voltage	see Fig.8	1.5	V
I_{Csat}	collector saturation current			
	BUT12		6	A
	BUT12A		5	A
I_C	collector current (DC)	see Figs 3 and 4	8	A
I_{CM}	collector current (peak value)	see Fig. 4	20	A
P_{tot}	total power dissipation	$T_{mb} \leq 25$ °C; see Fig.2	125	W
t_f	fall time	resistive load; see Figs 12 and 13	0.8	µs

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j\text{-}mb}$	thermal resistance from junction to mounting base	1	K/W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CESM}	collector-emitter peak voltage	V_{BE} = 0			
	BUT12		–	850	V
	BUT12A		–	1000	V
V_{CEO}	collector-emitter voltage	open base			
	BUT12		–	400	V
	BUT12A		–	450	V
I_{Csat}	collector saturation current				
	BUT12		–	6	A
	BUT12A		–	5	A
I_C	collector current (DC)	see Figs 3 and 4	–	8	A
I_{CM}	collector current (peak value)	see Fig. 4	–	20	A
I_B	base current (DC)		–	4	A
I_{BM}	base current (peak value)		–	6	A
P_{tot}	total power dissipation	$T_{mb} \leq 25$ °C; see Fig.2	–	125	W
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–	150	°C

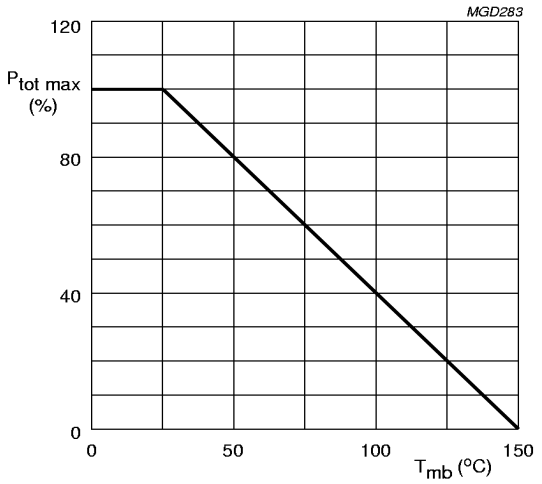
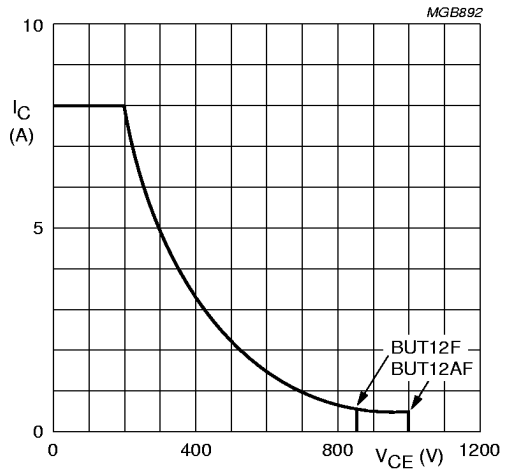


Fig.2 Power derating curve.



V_{BE} = –1 to –5 V; T_c = 100 °C.

Fig.3 Reverse bias SOAR.

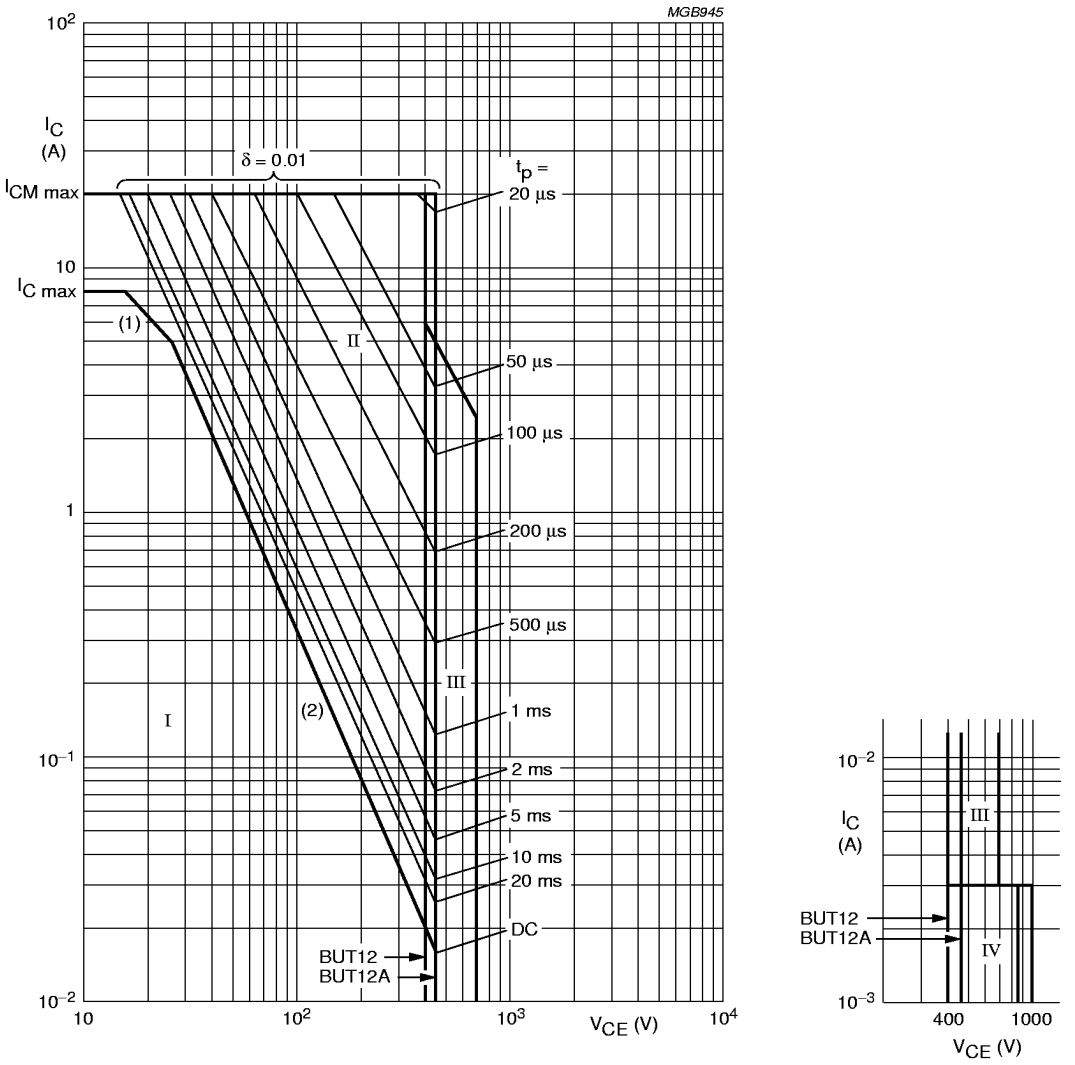
CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{CEOsust}$	collector-emitter sustaining voltage	I_C = 100 mA; I_{Boff} = 0; L = 25 mH; see Figs 6 and 7				
	BUT12		400	–	–	V
	BUT12A		450	–	–	V
V_{CEsat}	collector-emitter saturation voltage					
	BUT12	I_C = 6 A; I_B = 1.2 A; see Figs 8 and 10	–	–	1.5	V
	BUT12A	I_C = 5 A; I_B = 1 A; see Figs 8 and 10	–	–	1.5	V
V_{BEsat}	base-emitter saturation voltage					
	BUT12	I_C = 6 A; I_B = 1.2 A; see Fig.8	–	–	1.5	V
	BUT12A	I_C = 5 A; I_B = 1 A; see Fig.8	–	–	1.5	V
I_{CES}	collector-emitter cut-off current	$V_{CE} = V_{CESmax}$; V_{BE} = 0; note 1	–	–	1	mA
		$V_{CE} = V_{CESmax}$; V_{BE} = 0; T_j = 125 °C; note 1	–	–	3	mA
I_{EBO}	emitter-base cut-off current	V_{EB} = 9 V; I_C = 0	–	–	10	mA
h_{FE}	DC current gain	V_{CE} = 5 V; I_C = 10 mA; see Fig.11	10	18	35	
		V_{CE} = 5 V; I_C = 1 A; see Fig.11	10	20	35	
Switching times resistive load (see Figs 12 and 13)						
t_{on}	turn-on time					
	BUT12	I_{Con} = 6 A; $I_{Bon} = -I_{Boff}$ = 1.2 A	–	–	1	µs
	BUT12A	I_{Con} = 5 A; $I_{Bon} = -I_{Boff}$ = 1 A	–	–	1	µs
t_s	storage time					
	BUT12	I_{Con} = 6 A; $I_{Bon} = -I_{Boff}$ = 1.2 A	–	–	4	µs
	BUT12A	I_{Con} = 5 A; $I_{Bon} = -I_{Boff}$ = 1 A	–	–	4	µs
t_f	fall time					
	BUT12	I_{Con} = 6 A; $I_{Bon} = -I_{Boff}$ = 1.2 A	–	–	0.8	µs
	BUT12A	I_{Con} = 5 A; $I_{Bon} = -I_{Boff}$ = 1 A	–	–	0.8	µs
Switching times inductive load (see Figs 14 and 15)						
t_s	storage time					
	BUT12	I_{Con} = 6 A; I_{Bon} = 1.2 A; V_{CL} = 250 V; T_c = 100 °C	–	1.9	2.5	µs
	BUT12A	I_{Con} = 5 A; I_{Bon} = 1 A; V_{CL} = 300 V; T_c = 100 °C	–	1.9	2.5	µs
t_f	fall time					
	BUT12	I_{Con} = 6 A; I_{Bon} = 1.2 A; V_{CL} = 250 V; T_c = 100 °C	–	200	300	ns
	BUT12A	I_{Con} = 5 A; I_{Bon} = 1 A; V_{CL} = 300 V; T_c = 100 °C	–	200	300	ns

Note

1. Measured with a half-sinewave voltage (curve tracer).



T_{mb} < 25 °C.

I - Region of permissible DC operation.

II - Permissible extension for repetitive pulse operation.

(1) $P_{tot\ max}$ and $P_{tot\ peak\ max}$ lines.

(2) Second breakdown limits.

Fig.4 Forward bias SOAR.

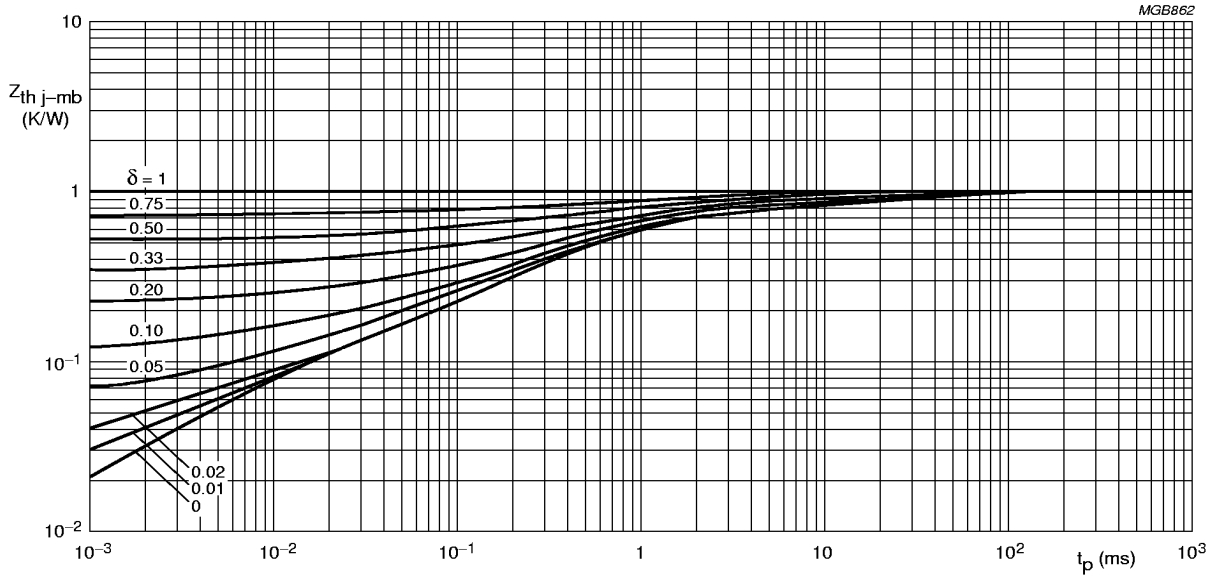


Fig.5 Transient thermal impedance.

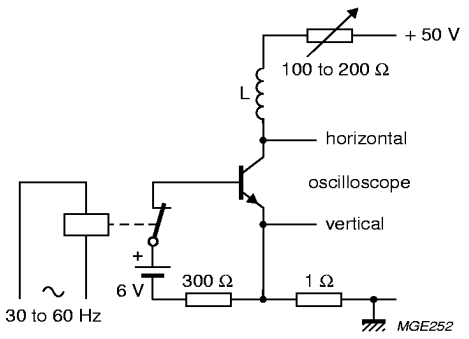


Fig.6 Test circuit for collector-emitter sustaining voltage.

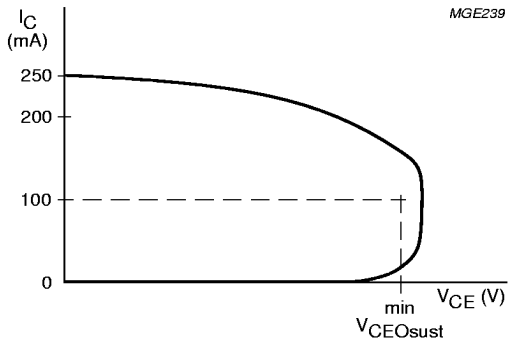
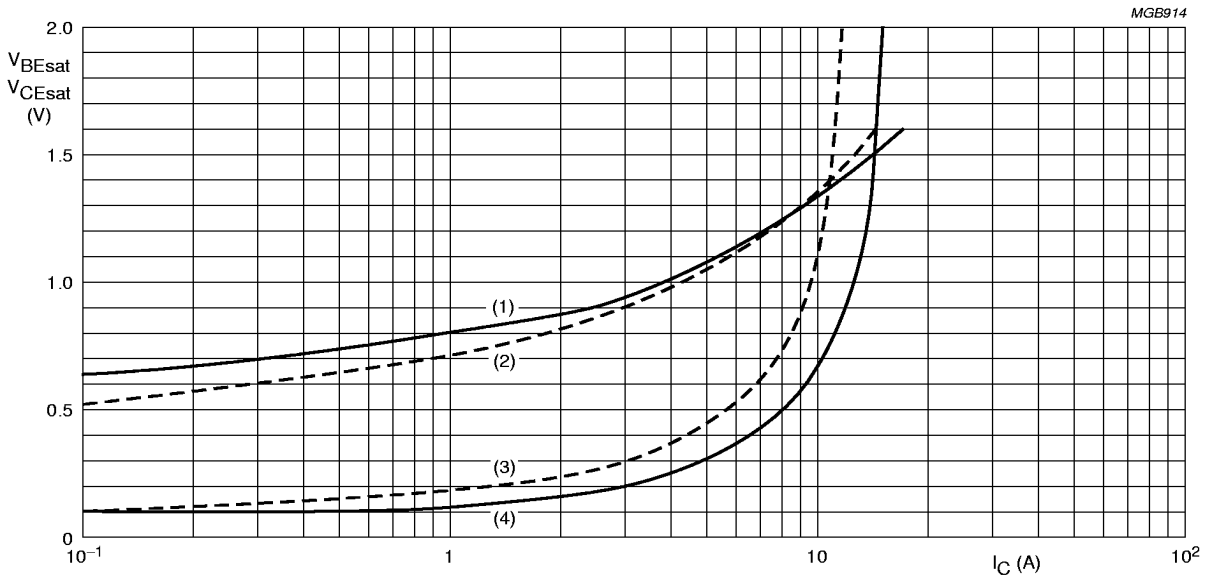


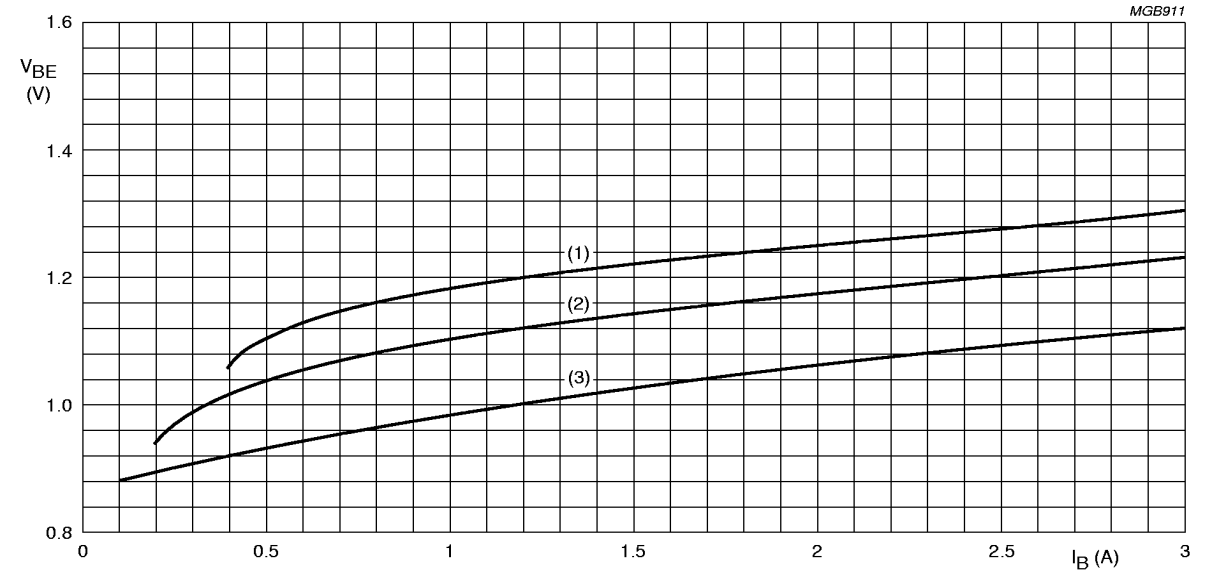
Fig.7 Oscilloscope display for collector-emitter sustaining voltage.



$I_C/I_B = 5$.

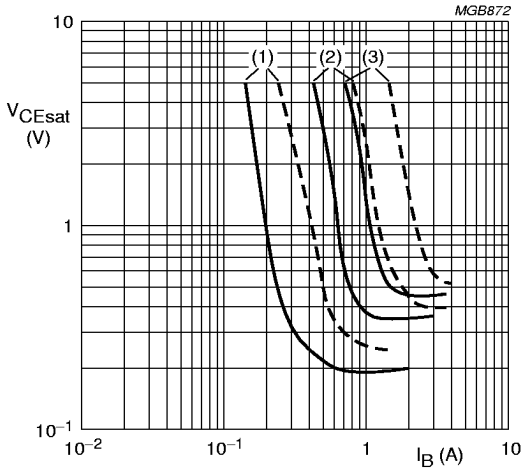
(1) V_{BE}; T_j = 25 °C.
(2) V_{BE}; T_j = 100 °C.
(3) V_{CE}; T_j = 100 °C.
(4) V_{CE}; T_j = 25 °C.

Fig.8 Base-emitter and collector-emitter saturation voltages as functions of collector current; typical values.



T_j = 25 °C.
(1) I_C = 8 A.
(2) I_C = 6 A.
(3) I_C = 3 A.

Fig.9 Base-emitter voltage as a function of base current; typical values.



(1) I_C = 3 A.
(2) I_C = 6 A.
(3) I_C = 8 A.
T_j = 25 °C; solid line: typical values; dotted line: maximum values.

Fig.10 Collector-emitter saturation voltage as a function of base current.

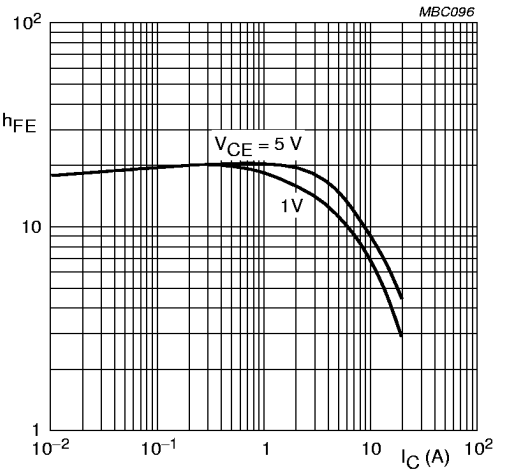
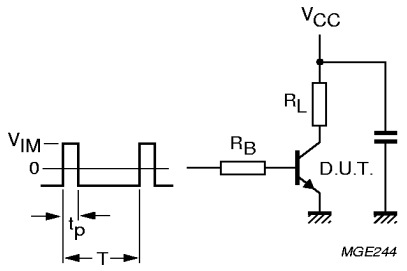
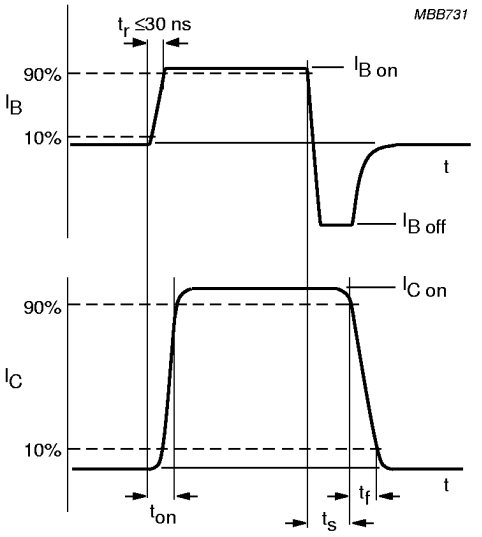


Fig.11 DC current gain; typical values.



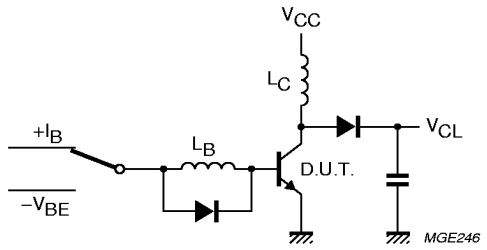
V_{CC} = 250 V; t_p = 20 µs; V_{IM} = −6 to +8 V; t_p/T = 0.01.
The values of R_B and R_L are selected in accordance with I_{Con} and I_{Bon} requirements.

Fig.12 Test circuit resistive load.



$t_r \leq 20$ ns.

Fig.13 Switching time waveforms with resistive load.



V_{CL} = up to 1000 V; V_{CC} = 30 V; V_{BE} = −1 to −5 V; L_B = 1 μH; L_C = 200 μH.

Fig.14 Test circuit inductive load and reverse bias SOAR.

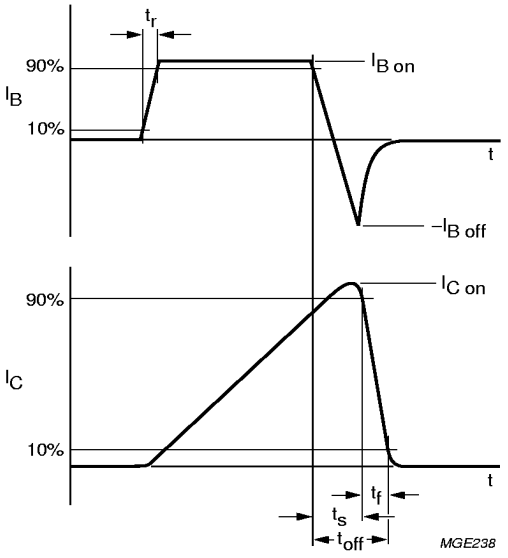
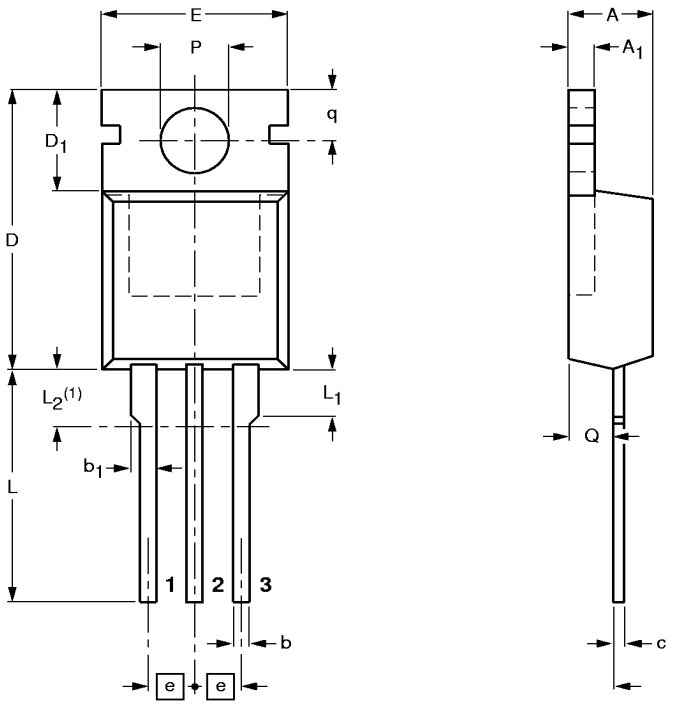
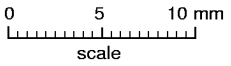


Fig.15 Switching time waveforms with inductive load.

PACKAGE OUTLINE

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220 **SOT78**





DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	b_1	c	D	D_1	E	e	L	L_1	$L_2^{(1)}$ max.	P	q	Q
mm	4.5 4.1	1.39 1.27	0.9 0.7	1.3 1.0	0.7 0.4	15.8 15.2	6.4 5.9	10.3 9.7	2.54	15.0 13.5	3.30 2.79	3.0	3.8 3.6	3.0 2.7	2.6 2.2

Note

1. Terminals in this zone are not tinned.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT78		TO-220				97-06-11